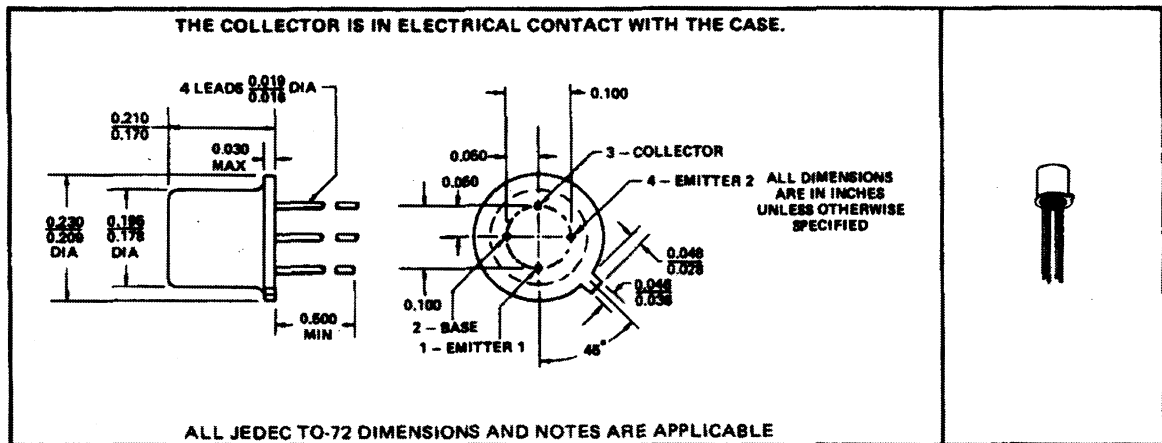


**TYPES 3N74 THRU 3N79
 N-P-N SILICON TRANSISTORS**

**DOUBLE-EMITTER TRANSISTORS
 DESIGNED FOR CHOPPER APPLICATIONS**

- Low Offset Voltage
- Excellent Thermal Stability
- Very Low Leakage . . . 2 nA max at 15 V (3N74, 3N75, 3N76)
- High Breakdown Voltage . . . 18 V min (3N74, 3N75, 3N76)

*mechanical data



*absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

	3N74	3N77
	3N75	3N78
	3N76	3N79
Collector-Base Voltage	50 V	40 V
Emitter-One-Collector Voltage (See Note 1)	18 V	12 V
Emitter-Two-Collector Voltage (See Note 1)	18 V	12 V
Emitter-One-Collector Voltage (See Note 2)	±18 V	±12 V
Emitter-One-Base Voltage	18 V	12 V
Emitter-Two-Base Voltage	18 V	12 V
Continuous Collector Current	←±20 mA→	
Continuous Base Current	←±20 mA→	
Continuous Emitter-One Current	←±10 mA→	
Continuous Emitter-Two Current	←±10 mA→	
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 3)	←300 mW→	
Continuous Device Dissipation at (or below) 25°C Case Temperature (See Note 4)	←600 mW→	
Storage Temperature Range	-65°C to 200°C	
Lead Temperature 1/16 Inch from Case for 10 Seconds	←230°C→	

- NOTES: 1. These values apply when the base and other emitter are open-circuited.
 2. These values apply when the collector is short-circuited to the base but open-circuited with respect to the emitters.
 3. Derate linearly to 175°C free-air temperature at the rate of 2 mW/°C.
 4. Derate linearly to 175°C case temperature at the rate of 4 mW/°C.

*JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

TYPES 3N74 THRU 3N79 N-P-N SILICON TRANSISTORS

*electrical characteristics at 25°C free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	3N77		3N78		3N79		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage $I_C = 100 \mu A, I_{E1} = I_{E2} = 0$	40		40		40		V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage $I_E = 10 \mu A, I_C = 0, \text{ See Note 5}$	12		12		12		V
$V_{(BR)E1E2}$	Emitter-Emitter Breakdown Voltage $I_{E1} = \pm 10 \mu A, V_{CB} = 0, \text{ See Note 6}$	± 12		± 12		± 12		V
I_{CBO}	Collector Cutoff Current $V_{CB} = 30 V, I_{E1} = I_{E2} = 0$	10		10		20		nA
I_{EBO}	Emitter Cutoff Current $V_{EB} = 5 V, I_C = 0, \text{ See Note 5}$	8		8		10		nA
$I_{E1E2(off)}$	Emitter Cutoff Current $V_{E1E2} = \pm 5 V, V_{CB} = 0, \text{ See Note 6}$ $V_{E1E2} = \pm 5 V, V_{CB} = 0, T_A = 100^\circ C, \text{ See Note 6}$	± 8		± 8		± 10		nA
$ V_{E1E2(off)} $	Emitter-Emitter Offset Voltage $I_B = 1 mA, I_{E1} = I_{E2} = 0, \text{ See Figures 1, } T_A = -25^\circ C, 25^\circ C, \text{ and } 100^\circ C$	60		100		200		μV
$ \Delta V_{E1E2(off)} / \Delta I_B$	Offset Voltage Change with Base Current [†] $I_{B(1)} = 1.5 mA, I_{B(2)} = 0.5 mA, I_{E1} = I_{E2} = 0$	25		50		75		μV
$ \Delta V_{E1E2(off)} / \Delta T_A$	Offset Voltage Change with Temperature [†] $I_B = 1 mA, I_{E1} = I_{E2} = 0, T_{A(1)} = 100^\circ C, T_{A(2)} = -25^\circ C$	75		125		175		μV
$r_{e1e2(on)}$	Small-Signal Emitter-Emitter On-State Resistance $I_B = 1 mA, I_{E1} = I_{E2} = 0, I_e = 100 \mu A, \text{ See Figure 2}$ $f = 1 kHz$	10	50	10	50	10	50	Ω
$ h_{fe} $	Small-Signal Common-Emitter Forward Current Transfer Ratio $V_{CE} = 5 V, I_C = 1 mA, f = 20 MHz, \text{ See Note 5}$	1.5		1.5		1.5		
C_{obo}	Common-Base Open-Circuit Output Capacitance $V_{CB} = 5 V, I_{E1} = I_{E2} = 0, f = 140 kHz$	8		8		10		pF
C_{ibo}	Common-Base Open-Circuit Input Capacitance $V_{EB} = 5 V, I_C = 0, f = 140 kHz, \text{ See Note 5}$	5		5		6		pF

NOTES: 5. These limits apply separately for each emitter with the other emitter open-circuited.

6. These parameters must be measured with the collector short-circuited to the base but open-circuited with respect to the emitters. The limits apply to both polarities of emitter-to-emitter voltage.

[†]Offset Voltage Change is defined as the magnitude of the algebraic difference between the offset voltages at two specified base currents or temperatures.

PARAMETER MEASUREMENT INFORMATION

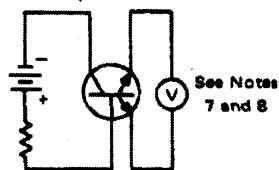


FIGURE 1

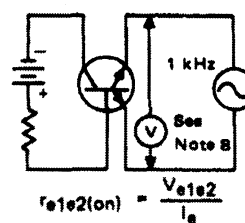


FIGURE 2

NOTES: 7. Care must be taken to avoid error due to thermocouple action.

8. The voltmeter impedance must be high enough that halving it does not change the measured value.

*JEDEC registered data